Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/625,645	CHRISTIAN ET	AL.
Examiner	Art Unit	
Leigh C. Maier	1623	

SEARCHED				
	JEAR			
Class	Subclass	Date	Examiner	
536	17.2 22.1 29.1	11/10/2006	LCM	
514	25 42	11/10/2006	LCM	
search	updated	7/12/2007	LCM	
514	62	7/12/2007	LCM	
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
536	17.2	7/12/2007	LCM
514	62	7/12/2007	LCM
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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
-STN structure search -EAST (transcripts attached)	11/10/2006	LCM	
-search updated in EAST	7/12/2007	LCM	
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